INTRODUCTION

The purpose of this algorithm is to create the means of developing capacitive sensing applications in systems affected by conducted noise. This document describes the ideas and concepts behind this algorithm, as well as the firmware implementation and tuning for PIC® mid-range microcontrollers with the Capacitive Sensing Module (CSM). Please refer also to AN1171, “How to use the Capacitive Sensing Module (CSM)” (DS01171).

DESCRIPTION

This algorithm is based on three distinct concepts.

The First Concept – Frequency Deviation

The first concept is that the system's frequency of oscillation can be disturbed by two factors, noise and finger presses, in three different scenarios:

A) Only a finger press affects the system (lack of noise)
B) Only noise affects the system
C) A composed action of both noise and finger press affect the system

First, let's define the term "deviation" as a modification of the oscillation frequency away from its natural value. In scenario A, due to the lack of noise, the frequency deviation will tend to be constant and easy to detect.

In cases B and C, the system's frequency of oscillation can be overpowered by the frequency of the disturbance source. This leads to the situation where the system's new oscillation frequency has a value close or equal to the frequency of the disturbance source. This new frequency presents a deviation in regard with the natural frequency of the system, which can be anywhere from multiple orders of magnitude to zero.

The Second Concept – Most Pressed Button

The second concept states that conducted noise will affect the whole sensor pool (case B), causing deviations similar in magnitude to be present on all the sensor inputs. A pressed sensor will show a deviation of a much higher magnitude than the other sensors, with or without the noise (case A and C). Thus, in case A, the pressed sensor will likely be the only one showing deviation. In case C, all the sensors are already affected by noise and show deviation. Here, the pressed sensor will show an additional deviation. This is the largest deviation with respect to the deviations of the other sensors which are affected only by noise, and not also by a finger press. This second concept can be simplified best by the expression "searching for the most pressed button."

The Third Concept – Multiple Scan Modes

The third concept states that more than one current range needs to be employed at a certain time in order to catch deviations occurring in scenarios B and C. Naturally, a capacitive sensing system can run at different frequencies of oscillations, according to the current source that is employed.

The relationship between the current through a capacitor and the rate of change of the voltage across the capacitor is the following:

**EQUATION 1:**

\[ I = \frac{C \Delta v}{\Delta t} \]

In this equation, the current is inversely proportional with the time. If we modify the current, we modify the time, hence the frequency.

While deviations produced in scenario A can be detected at all times, it is not the case with those deviations that appear in the other two scenarios. Here, if the noise frequency has a value almost equal to one of the two oscillation frequencies employed by the system, the result is a minor or zero deviation in that current range. However, the deviation will show up when a different current range is used because the system runs now with a frequency which is distinct than that of the noise.
To summarize, let’s say that two current ranges used alternately means that there are two sensor readings at two different natural oscillation frequencies. If the deviations can’t be detected in one range, they will be detected in the other one.

Consequently, all deviations caused by disturbance sources in scenarios B and C can be detected by performing a logic OR between the results of the scans at different frequencies of oscillation.

FIRMWARE IMPLEMENTATION AND TUNING

Sampling

The firmware uses a dual scan mechanism for acquiring pulses from the CSM. The capacitive sensing oscillator is set to run in two different ranges: the high range and the medium range. Thus, we obtain two separate oscillation frequencies and the system is able to scan alternately for deviations using two independent firmware branches, one for each setting of the oscillator. The results of the two branches are OR’ed together to obtain the final response of the system. This is an effort to detect all possible deviation in frequency. Sampling at the same time, in parallel, for two separate values of the oscillation frequency increases the chances of detecting a deviation and thus, a possible press.

There are two methods of sampling the channels of the CSM:

• A predefined number of pulses from the CSM are acquired by one timer, while another timer is counting the time taken by this operation. This method is called “period measurement.” Please refer to AN1268, “mTouch™ Capacitive Sensing Using Period Method” (DS01268).

• A timer is used to create a time window during which pulses from the CSM are counted by another timer. This method is called “frequency measurement.”

The attached firmware is using the “period measurement” method to keep track of the oscillation frequency of the CSM channels. Figure 1 illustrates how TMR0 acts as a counter, acquiring pulses coming from CSM, while TMR1 measures the period.

FIGURE 1: PERIOD MEASUREMENT

One advantage of this method is that one can create a faster sampling rate. The timer acquiring the pulses from the CSM can be set to overflow after a specific number of pulses have been counted.

There are two labels which can be modified by the user in order to set the reload values for counter Timer0:

• **TMR0_HIGH** will be the value loaded into Timer0 each time a sampling step is performed for the high range of the capacitive sensing oscillator.

• **TMR0_MED** will be the value loaded into Timer0 each time a sampling step is performed for the medium range of the capacitive sensing oscillator.

The two reload values of Timer0 do not have to be equal, as in one range the frequency of oscillation is greater than in the other range. By defining these labels, the user sets the sampling rates in each of the two oscillator ranges: high and medium.

Storing the Deviations

For each setting/range of the oscillator, the channels are scanned consecutively. As soon as a key shows a shift in frequency (a threshold is crossed), the system runs a procedure that gathers data about the deviations of all keys (each key will have its deviation stored in a value, no matter if it is zero). The data gathering can be performed in one or more steps, each step consisting of the storage of the deviations of the keys. This procedure can be executed in a predefined number of steps. A higher number of steps leads to a higher resolution of the deviations and makes it easier to differentiate between them. However, the user should keep in mind that too many steps will slow down the system’s response significantly. The label **SAMPLING_MULTIPLIER** defines the number of steps executed in this procedure.
This deviation-storing procedure is performed with the purpose of having a clear perspective about the situation of the keys deviations when one or more of them starts to show modifications in the oscillation frequency. The labels that define the threshold for the deviation in frequency are FIX_TRIP_MED for the medium range of the capacitive sensing oscillator, and FIX_TRIP_HIGH for the high range.

Averaging

Averaging is performed in a slow, gated manner.

- Slow: this is an effort to avoid deviations with a slow slope that might affect the keys values. For example, if a finger is slowly moving towards a key, it will likely create a small deviation. In a faster averaging system, this will typically be included in the new average values and cannot be seen. When the finger suddenly leaves the board, it creates a great amount of deviation that could be seen by the system as a false press. A slower averaging system will likely avoid this situation. The small deviation created by the slowly approaching finger will not be averaged right away and will build up into a greater deviation that will be detected as a potential press by the system. The label defining how slow the average is performed is: AVG_DELAY.

- Gated: due to the unpredictable nature of the noise, it makes sense not to include its potential effect in the average values. Thus, if a deviation is present when running on either of the two settings of the oscillator, then no averaging is performed.

Figure 2 shows the gated average principle.

Finding the Most Pressed Button

The sorting procedure decides which one of the keys has the largest deviation in frequency, and thus, which one is going to be signaled as pressed. This deviation has to be larger than the others by a factor of 3 by default. This can be configured by the user through the DEVIATION_MULTIPLIER label. This label defines how many times the highest deviation must be greater than any of the other deviations and can be chosen according to the target application.

Thus, if a key exhibits a deviation that is larger than the other keys deviations by at least delta, then that specific key might be pressed.

Figure 3 illustrates how a key might be detected as the most pressed. When noise is injected in the power rails, all buttons exhibit about the same deviation in frequency (compared to the normal operation). Next, Button 0 shows additional deviation compared to the other keys, which qualifies it as a potentially pressed button.
FIGURE 3: DETECTING THE MOST PRESSED KEY

Debouncing

The debouncing routine is executed next, and there, the target is the key which exhibits the largest deviation. A debounce cycle consist of two parts: a sampling part and a sorting part. During each debounce step, all the keys are scanned and the sorting procedure searches for the key with the largest deviation. The user can define the WINNER_DEBOUNCE_MAX label for setting up the maximum number of debouncing cycles. Depending on the application, it might take fewer or several cycles of debouncing before a key can be signaled as pressed.

The sorting procedure is supposed to highlight the most pressed key. However, it might happen that, although some or all keys show deviations, there isn’t a clear winner which meets the DEVIATION_MULTIPLIER criterion. Some examples illustrating this situation are: an imprecise finger touch that targets the border between two keys, more than one key pushed or noise.

If this scenario (where although keys are showing deviation, there isn’t a clear winner) repeats, the firmware will clear all the keys flags. This means that the capacitive sensing system finds itself in an undefined state and doesn’t have a clear response to be reported to the main application.

Signaling

To signal a key ON, there is a basic operation of setting the flag corresponding to the most pressed key. At the same time, the flags of the other keys are cleared. In this way, the system follows the rule stating that only one key can be the most pressed at a time.

The procedure for declaring a key in an OFF state is much simpler. If the deviation of a key drops below the threshold, then that specific key is run through a debouncing routine. The number of times this routine is executed before a key can be signaled as OFF is set using the DEBOUNCE_OFF label. The complete list and a more detailed description of the variables and labels that are used by the firmware as tuning parameters, can be found in the header file TuningParameters.h.

The firmware occupies about 1.6K of program memory and about 98 bytes of data memory for a 2-button version. Each increment of the number of buttons will cause the firmware to use 18 additional bytes of data memory (see Table 1 below).

<table>
<thead>
<tr>
<th>TABLE 1: FLASH/RAM USAGE</th>
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<tr>
<td></td>
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<td>Flash</td>
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<td>RAM</td>
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Figure 4 is a simplified flowchart of the firmware. It contains the basic description of one of the two branches that is designated for an oscillator setting. Each branch scans all the keys before passing the control to the other one. A press/release is signaled by either one of the two branches.
FIGURE 4: FIRMWARE FLOWCHART

Sample

Calculate Deviation

Y

Deviations > Thr

N

Debounce Key’s OFF State

Signal Key OFF

Clear Key’s Deviation Flag

Debounce Key’s OFF State

Store all Keys Deviations

Sort the Highest Deviation

Y

Success?

N

Debounce the Key with the Highest Deviation

Signal the Most Pressed Key

Debounce Unclear Press

Averaging Enabled

Signal All Keys OFF

Switch to the other Oscillator Setting

NY

Debounce Key’s OFF State

Clear Key’s Deviation Flag

Averaging Enabled

All Deviation Flags Cleared

N

Y

All Keys Sampled?

Switch to the other Oscillator Setting

Debounce Key’s OFF State

Store all Keys Deviations

Sort the Highest Deviation

Y

Success?

N

Debounce the Key with the Highest Deviation

Signal the Most Pressed Key

Debounce Unclear Press

Averaging Enabled

Signal All Keys OFF

Switch to the other Oscillator Setting

Debounce Key’s OFF State

Store all Keys Deviations

Sort the Highest Deviation

Y

Success?

N

Debounce the Key with the Highest Deviation

Signal the Most Pressed Key

Debounce Unclear Press

Averaging Enabled

Signal All Keys OFF

Switch to the other Oscillator Setting

Debounce Key’s OFF State

Store all Keys Deviations

Sort the Highest Deviation

Y

Success?

N

Debounce the Key with the Highest Deviation

Signal the Most Pressed Key

Debounce Unclear Press

Averaging Enabled

Signal All Keys OFF

Switch to the other Oscillator Setting

Debounce Key’s OFF State

Store all Keys Deviations

Sort the Highest Deviation

Y

Success?

N

Debounce the Key with the Highest Deviation

Signal the Most Pressed Key

Debounce Unclear Press

Averaging Enabled

Signal All Keys OFF

Switch to the other Oscillator Setting

Debounce Key’s OFF State

Store all Keys Deviations

Sort the Highest Deviation

Y

Success?

N

Debounce the Key with the Highest Deviation

Signal the Most Pressed Key

Debounce Unclear Press

Averaging Enabled

Signal All Keys OFF

Switch to the other Oscillator Setting

Debounce Key’s OFF State

Store all Keys Deviations

Sort the Highest Deviation

Y

Success?

N

Debounce the Key with the Highest Deviation

Signal the Most Pressed Key

Debounce Unclear Press

Averaging Enabled

Signal All Keys OFF

Switch to the other Oscillator Setting
CONCLUSION

This algorithm is designed as a solution for touch applications operating in a noisy environment. The firmware implementation presents a high degree of customization, which allows the user to tune the firmware for a specific target application.

For more information on Microchip’s mTouch™ Sensing solutions, please check our web site at www.microchip.com/mtouch.

REFERENCES

AN1101, “Introduction to Capacitive Sensing” (DS01101)
AN1103, “Software Handling for Capacitive Sensing” (DS01103)
AN1171, “How to use the Capacitive Sensing Module (CSM)” (DS01171)
AN1268, “mTouch™ Capacitive Sensing Using Period Method” (DS01268)

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